Notice of References Cited

Application/Control No. 10/585,292	Applicant(s)/Patent Under Reexamination YANG ET AL.		
Examiner	Art Unit		
Jason Mitchell	2193	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,118,940 A	09-2000	Alexander et al.	717/127
*	В	US-6,311,325 B1	10-2001	Levine et al.	717/128
*	С	US-2002/0040470 A1	04-2002	Guthrie et al.	717/126
*	D	US-2002/0091995 A1	07-2002	Arnold et al.	717/124
*	Е	US-2002/0108107 A1	08-2002	Darnell et al.	717/153
*	F	US-6,658,557 B1	12-2003	McCoy et al.	712/227
*	G	US-2003/0225917 A1	12-2003	Partamian et al.	709/310
*	Н	US-2004/0010785 A1	01-2004	Chauvel et al.	717/158
*	Т	US-2004/0193395 A1	09-2004	Paulraj, Dominic	703/022
*	J	US-2005/0223368 A1	10-2005	Smith et al.	717/128
*	к	US-6,961,930 B1	11-2005	Waldspurger et al.	717/141
*	L	US-2007/0143743 A1	06-2007	Cobb et al.	717/127
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	s					
	т					

NON-PATENT DOCUMENTS

HONT ALERT DOGGLERTO				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	B.S. Baker "A Program for Identifying Duplicated Code", 1992, Proc. Computing Science and Statistics: 24th Symp. Interface, vol. 24, pp. 49-57.		
Γ	v	S. Ducasse, M. Rieger, S. Demeyer "A Language Independent Approach for Detecting Duplicated Code", 1999, Proceeding of the IEEE International Conference on Software Maintenance, pg. 109.		
	w			
	×			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.